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| Notice of References Cited | Application/Control No. 10/022,263 | Applicant(s)/Patent Under Reexamination ONO ET AL. | |
| | Examiner Daniel I Walsh | Art Unit 2876 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,595,413 | 07-2003 | Sugita, Kazunari | 235/380 |
| * | B | US-6,502,078 | 12-2002 | Kasai et al. | 705/41 |
| * | C | US-4,375,032 | 02-1983 | Uchida, Yasuo | 235/380 |
| * | D | US-6,382,505 | 05-2002 | Takami et al. | 235/379 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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